

5A, 30V Dual N-Channel Power MOSFET

GENERAL DESCRIPTION

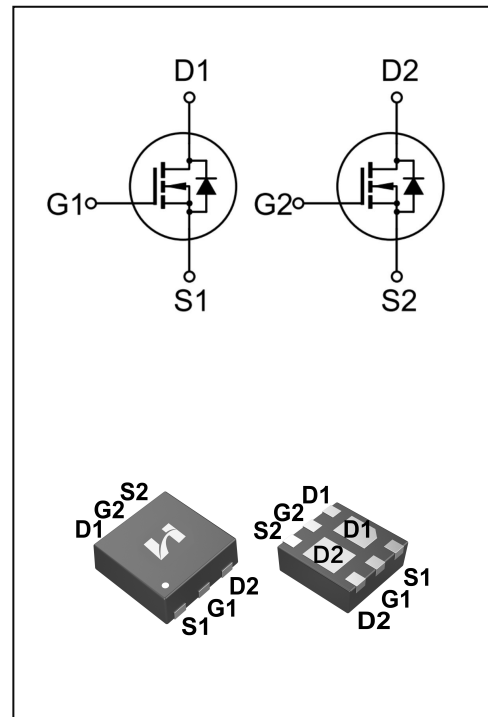
The Power MOSFET has extremely low on resistance, making it especially suitable for applications which require superior power density and outstanding efficiency.

Features

- ◆ $V_{DS}=30V, I_D=5A$
- ◆ $R_{DS(ON)}$
 TYP: $15.5m\Omega @ V_{GS}=10V$
 TYP: $23.5m\Omega @ V_{GS}=4.5V$

Applications

- ◆ Power faction correction (PFC)
- ◆ Switched mode power supplies (SMPS)
- ◆ Uninterruptible power supply (UPS)
- ◆ LED lighting power



ORDERING INFORMATION

Part No.	Package	Marking	Material	Packing
SFR0305T2	DFN2*2-6L	0305	Pb Free	Reel

ABSOLUTE MAXIMUM RATINGS (T_J=25°C unless otherwise noted)

Characteristics		Symbol	Ratings	Unit
Drain-Source Voltage		V _{DS}	30	V
Gate-Source Voltage		V _{GS}	±20	
Drain Current	T _C = 25°C	I _D	5	A
	T _C = 75°C		3.6	
Drain Current Pulsed(Note 1)		I _{DM}	20	
Power Dissipation(T _C =25°C) -Derate above 25°C		P _D	1.7	W
Operation Junction Temperature Range		T _J	-55~+150	°C
Storage Temperature Range		T _{stg}	-55~+150	
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		TL	300	

ELECTRICAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain -Source Breakdown Voltage	B _{VDS}	V _{GS} = 0V, I _D = 250μA	30	--	--	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} = 30V, V _{GS} = 0V	--	--	1	uA
Gate-Source Leakage Current	I _{GSS}	V _{GS} = 20V, V _{DS} = 0V	--	--	100	nA
Gate-Source Leakage Current	I _{GSS}	V _{GS} = -20V, V _{DS} = 0V	--	--	-100	
On Characteristics						
Gate Threshold Voltage	V _{GS(th)}	V _{GS} = V _{DS} , I _D = 250μA	1.0	1.45	2.0	V
Static Drain- Source On State Resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 5.0A	--	15.5	30	mΩ
		V _{GS} = 4.5V, I _D = 4.0A	--	23.5	35	
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{DS} = 15V V _{GS} = 0V f=1.0MHZ	--	585	--	pF
Output Capacitance	C _{oss}		--	51	--	
Reverse Transfer Capacitance	C _{rss}		--	43	--	
Switching Characteristics						
Turn-on Delay Time	t _{d(on)}	V _{DD} = 10V, V _{GS} = 4.5V R _G = 6Ω, I _D = 5.0A (Note 2.3)	--	9.6	--	nS
Turn-on Rise Time	t _r		--	14.8	--	
Turn-off Delay Time	t _{d(off)}		--	28.4	--	
Turn-off Fall Time	t _f		--	6.5	--	
Total Gate Charge	Q _g	V _{DS} =15V, I _D =5A V _{GS} =4.5V (Note 2.3)	--	11.2	--	nC
Gate-Source Charge	Q _{gs}		--	2.1	--	
Gate-Drain Charge	Q _{gd}		--	3.5	--	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I_S	Integral Reverse P-N Junction Diode in the MOSFET	--	--	5	A
Pulsed Source Current	I_{SM}		--	--	20	
Diode Forward Voltage	V_{SD}	$I_S = 5A, V_{GS} = 0V$	--	0.8	1.2	V

NOTE:

- 1.Pulse width limited by maximum junction temperature
- 2.Pulse Test: Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$
- 3.Essentially independent of operating temperature

Typical Performance Characteristics

Figure 1. Output Characteristics

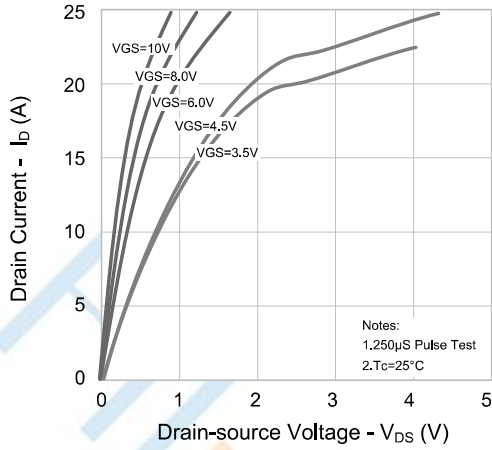


Figure 2. Transfer Characteristics

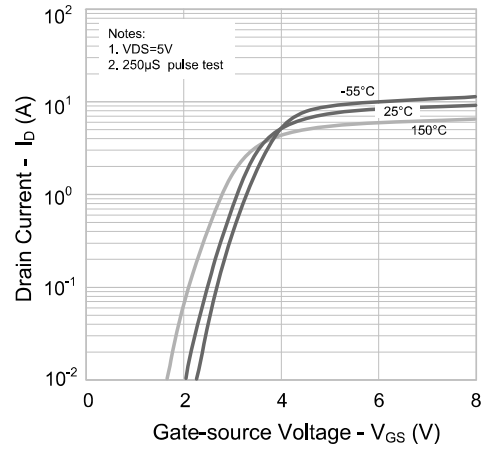


Figure 3. On-resistance vs. Drain Current

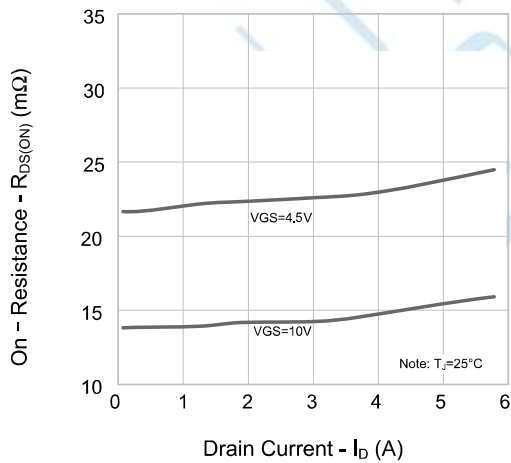


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

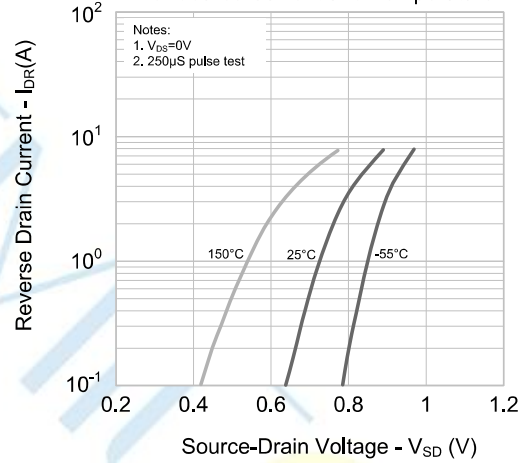


Figure 5. Capacitance Characteristics

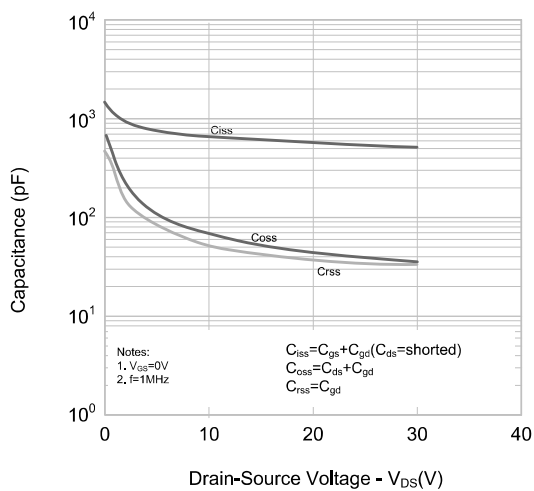
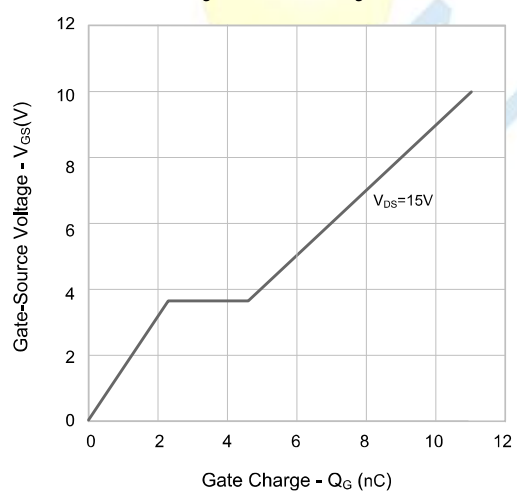
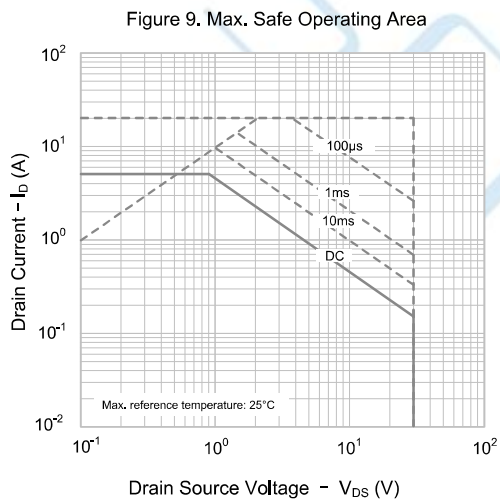
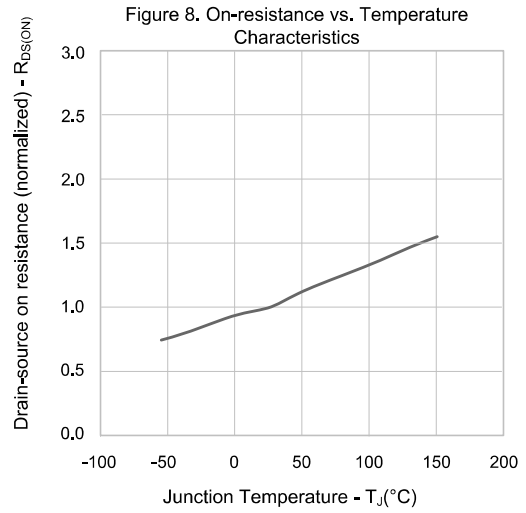
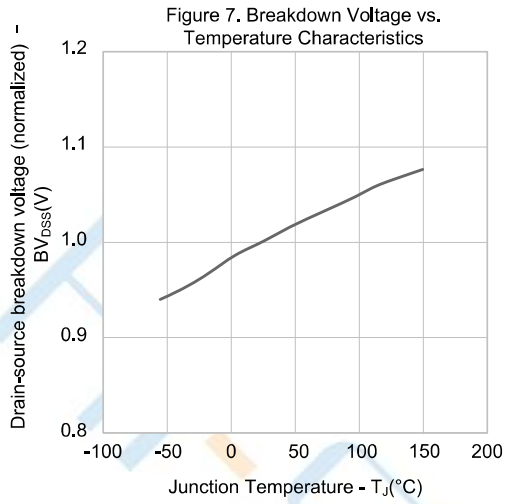


Figure 6. Gate Charge

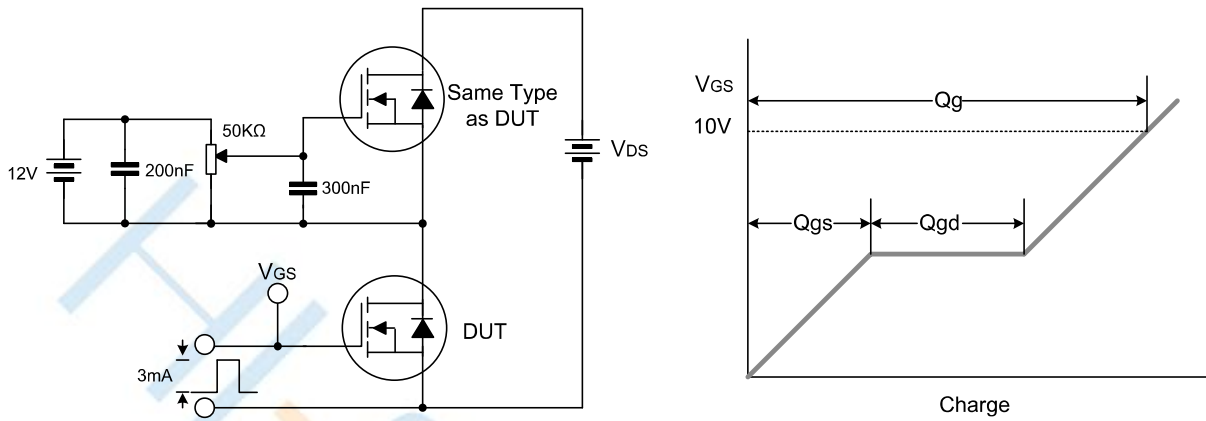


Typical Performance Characteristics

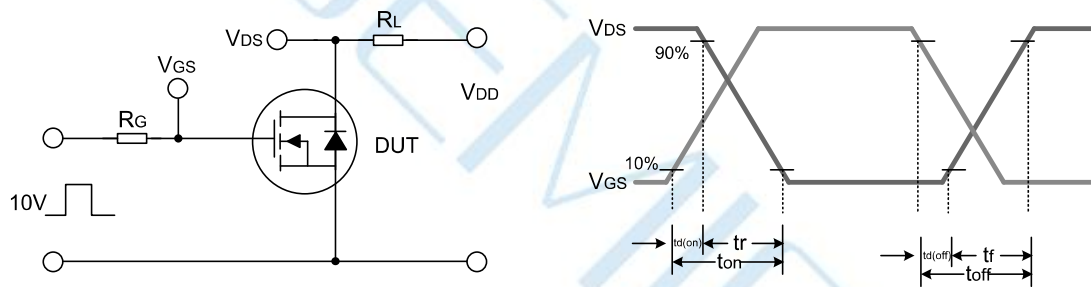


Test Circuit

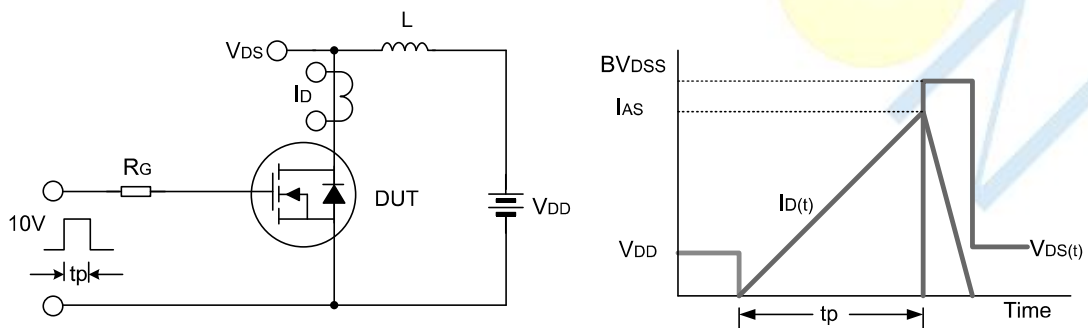
Gate Charge Test Circuit & Waveform



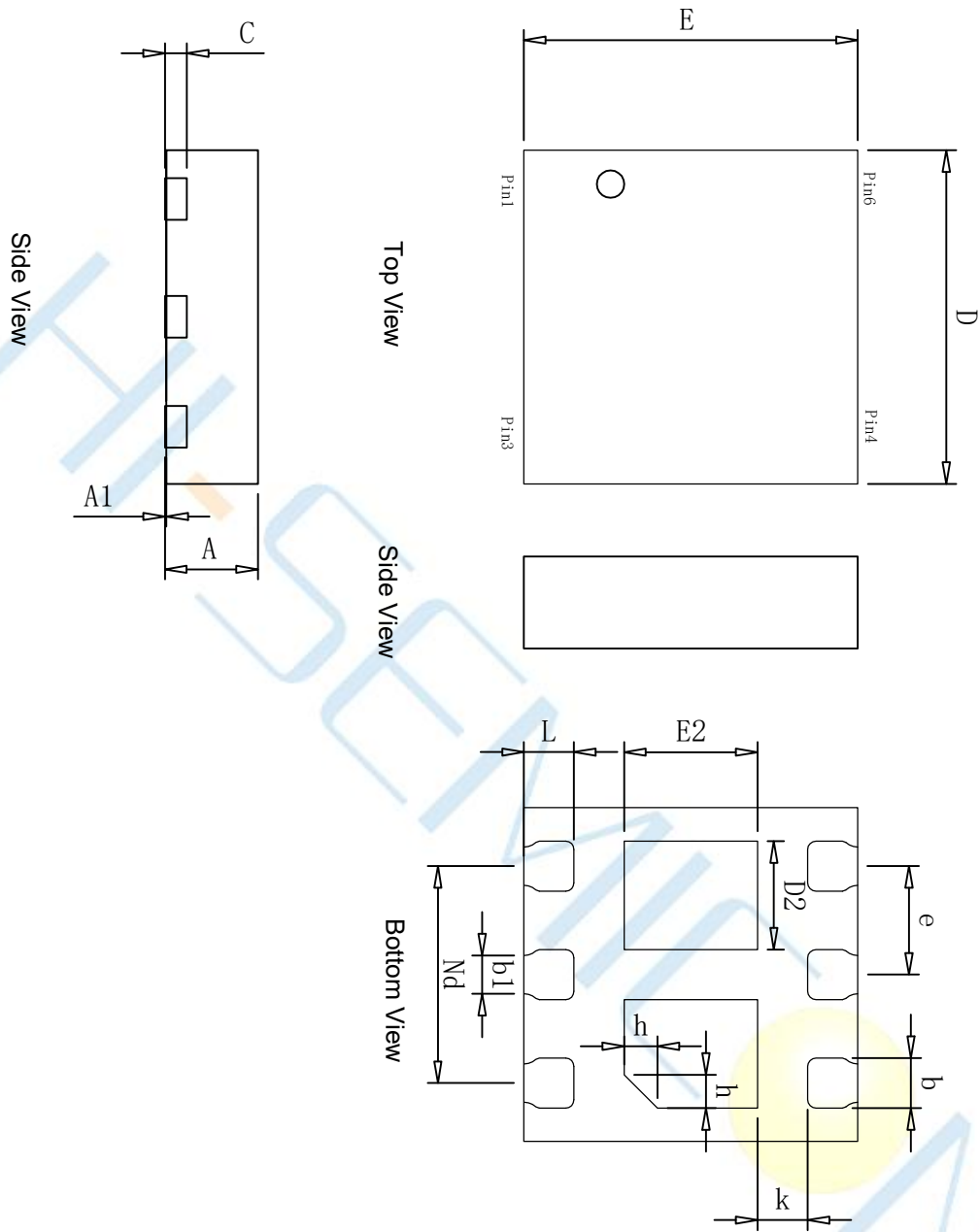
Resistive Switching Test Circuit & Waveform



Unclamped Inductive Switching Test Circuit & Waveform



Package Dimensions of DFN2*2-6L



SYMBOL	MILLIMETER		
	MIN	MON	MAX
A	0.45	0.55	0.65
A1	--	0.02	0.05
b	0.25	0.30	0.35
b1	0.230 REF.		
c	0.203 REF.		
D	1.90	2.00	2.10
D2	0.60	0.65	0.70
e	0.65 BSC		
E	1.90	2.00	2.10
E2	0.75	0.80	0.85
L	0.25	0.30	0.35
h	0.15	0.20	0.25
K	0.30 TYP		
Nd	1.30 TYP		

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